

March 2013

# FQD7N30 / FQU7N30 N-Channel QFET MOSFET

**300 V, 5.5 A, 700 m**Ω

# **Description**

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 5.5 A, 300 V,  $R_{DS(on)}$  = 700 m $\Omega$  (Max) @V<sub>GS</sub> = 10 V,  $I_D$  = 2.75 A
- Low Gate Charge (Typ. 13 nC)
- · Low Crss (Typ. 12 pF)
- 100% Avalanche Tested



## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD7N30 / FQU7N30	Units	
V <sub>DSS</sub>	Drain-Source Voltage		300	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		5.5	Α	
	- Continuous (T <sub>C</sub> = 100°C)		3.48	Α	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	22	Α	
$V_{GSS}$	Gate-Source Voltage		± 30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	380	mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	5.5	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns	
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W	
	Power Dissipation (T <sub>C</sub> = 25°C)		50	W	
	- Derate above 25°C		0.4	W/°C	
$T_J$ , $T_{STG}$	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	$R_{\theta JA}$ Thermal Resistance, Junction-to-Ambient		110	°C/W

<sup>\*</sup> When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 250  \mu\text{A}$	300			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.3		V/°C
Inss	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 300 V, V <sub>GS</sub> = 0 V			1	μА
		V <sub>DS</sub> = 240 V, T <sub>C</sub> = 125°C			10	μА
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
On Cha	aracteristics			•		•
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.75 A		0.53	0.7	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 2.75 A (Note 4)		4.0		S
C <sub>oss</sub> C <sub>rss</sub>	Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		100 12	130 16	pF pF
C <sub>rss</sub>	Reverse Transfer Capacitance			12	16	pF
Switch	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 150 V, I <sub>D</sub> = 7.0 A,		13	35	ns
t <sub>r</sub>	Turn-On Rise Time	$R_{G} = 25 \Omega$		75	160	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	11.6 20 32		25	60	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5		35	80	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 240 V, I <sub>D</sub> = 7.0 A, V <sub>GS</sub> = 10 V		13	17	nC
Q <sub>gs</sub>	Gate-Source Charge			3.4		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5	)	6.4		nC
	Source Diode Characteristics a	nd Maximum Ratings	·			
Drain-S		Maximum Continuous Drain-Source Diode Forward Current			5.5	Α
Drain-S		ode Forward Current			5.5	A
					22	A
I <sub>S</sub>	Maximum Continuous Drain-Source Did					
Is	Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	Forward Current			22	Α

#### Notes:

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 21mH,  $I_{AS}$  = 5.5A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $I_{SD}$  ≤ 7.0A, di/dt ≤ 200A/ $\mu$ s,  $V_{DD}$  ≤ BV $_{DSS}$ , Starting  $T_{J}$  = 25°C 4. Pulse Test : Pulse width ≤ 300 $\mu$ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

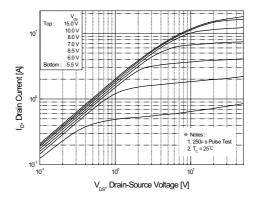


Figure 1. On-Region Characteristics

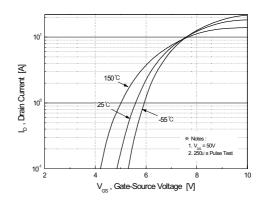


Figure 2. Transfer Characteristics

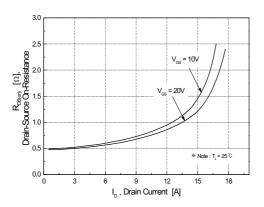


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

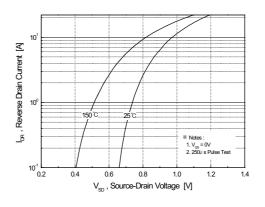


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

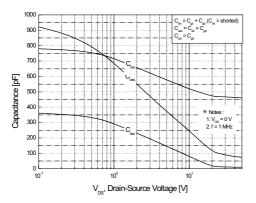


Figure 5. Capacitance Characteristics

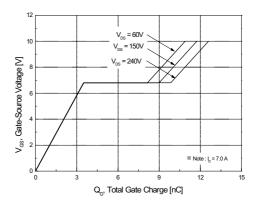


Figure 6. Gate Charge Characteristics

# Typical Characteristics (Continued)

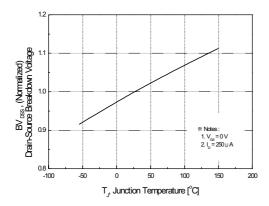
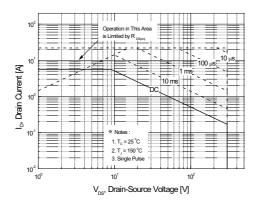


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



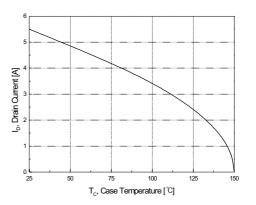


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

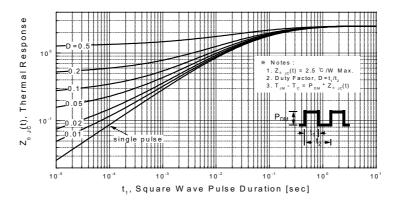
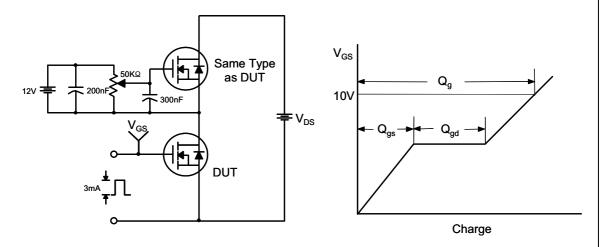
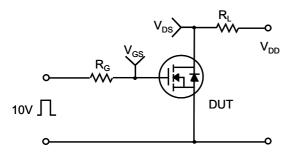


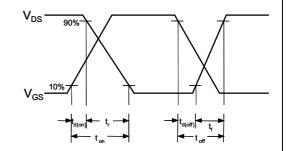
Figure 11. Transient Thermal Response Curve

#### **Gate Charge Test Circuit & Waveform**

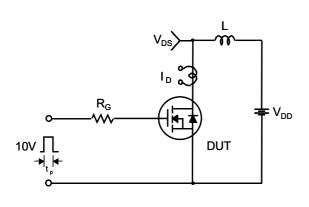


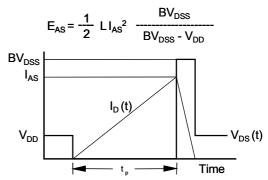
## **Resistive Switching Test Circuit & Waveforms**



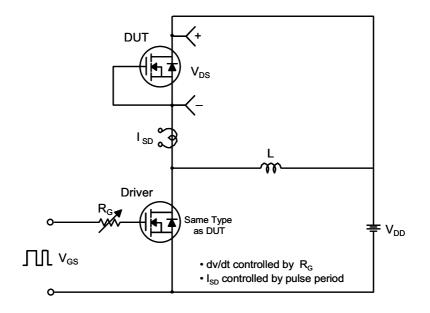


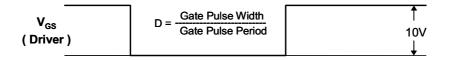
#### **Unclamped Inductive Switching Test Circuit & Waveforms**

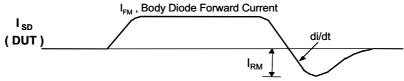




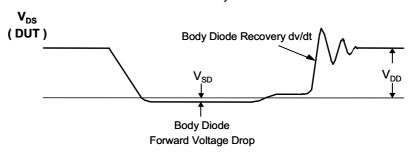
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





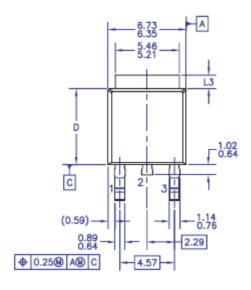


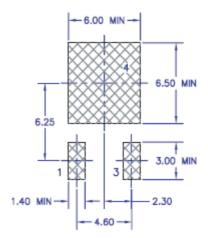
Body Diode Reverse Current



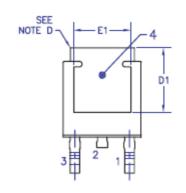
## **Package Dimensions**

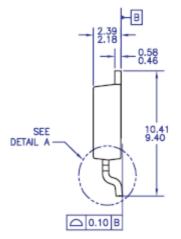
D - PAK

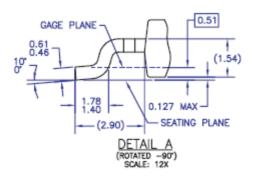




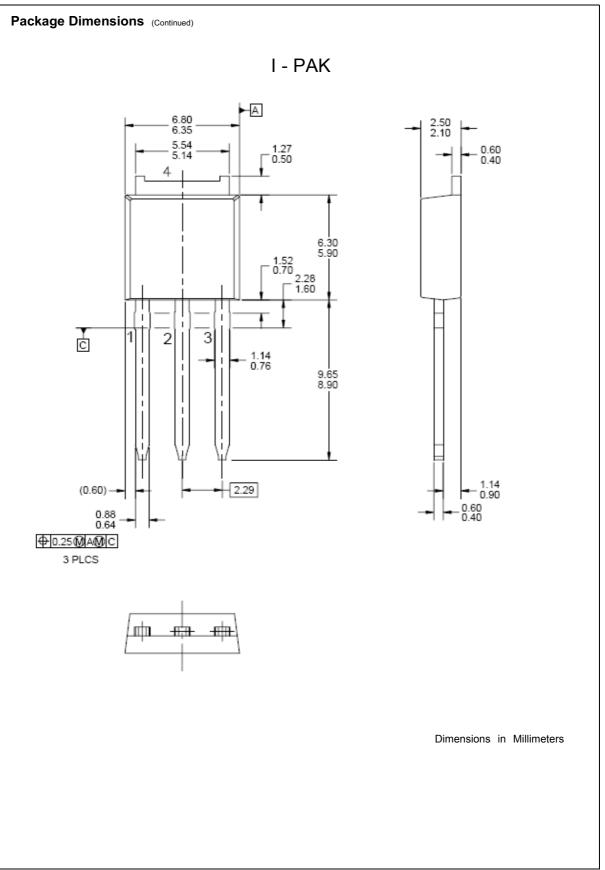
LAND PATTERN RECOMMENDATION







Dimensions in Millimeters







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Rev 164